











PCM1753-Q1, PCM1754-Q1

SLES254D - APRIL 2010 - REVISED JULY 2015

PCM175x-Q1 24-Bit 192-kHz Sampling Enhanced Multi-Level Delta-Sigma **Audio Digital-to-Analog Converter**

Features

- Qualified for Automotive Applications
- AEC-Q100 Qualified With the Following Results:
 - Device Temperature Grade 2: –40°C to 105°C Ambient Operating Temperature Range
 - Device HBM ESD Classification Level 2
 - Device CDM ESD Classification Level C4B
- 24-Bit Resolution
- Analog Performance ($V_{CC} = 5 \text{ V}$)
 - Dynamic Range: 106 dB
 - SNR: 106 dB, Typical
 - THD+N: 0.002%, Typical
 - Full-Scale Output: 4 V_{PP}, Typical
- 4x and 8x Oversampling Digital Filter
 - Stop-Band Attenuation: –50 dB
 - Pass-Band Ripple: ±0.04 dB
- Sampling Frequency: 5 kHz to 200 kHz
- System Clock: 128 f_S, 192 f_S, 256 f_S, 384 f_S, 512 f_S, 768 f_S, 1152 f_S with Auto Detect
- Hardware Control (PCM1754-Q1)
 - I²S and 16-Bit Word, Right-Justified
 - 44.1 kHz Digital De-Emphasis
 - Soft Mute
 - Zero Flag for L-, R-Channel Common Output
- Power Supply: 5-V Single Supply
- Small 16-Lead SSOP Package, Lead-Free

2 Applications

- Automotive Infotainment and Cluster
- A/V Receivers
- **HDTV Receivers**
- Car Audio Systems
- Other Applications Requiring 24-Bit Audio

3 Description

The PCM175x-Q1 family of devices is a CMOS, monolithic, integrated circuit, which includes stereo digital-to-analog converters and support circuitry in a small 16-lead SSOP package. The data converters use TI's enhanced multilevel delta-sigma architecture, which employs 4th-order noise shaping and 8-level amplitude quantization to achieve excellent dynamic performance and improved tolerance to clock jitter. The PCM175x-Q1 family of devices accepts industrystandard audio data formats with 16- to 24-bit data, providing easy interfacing to audio DSP and decoder chips. Sampling rates up to 200 kHz are supported. A full set of user-programmable functions is accessible through a three-wire serial control port, which supports register write functions.

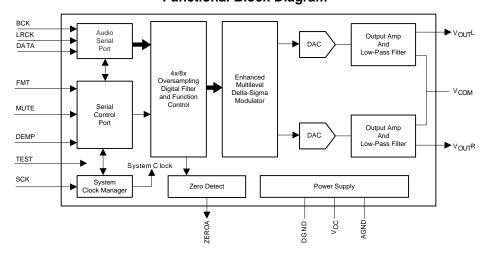
The PCM1753-Q1 device is pin-compatible with the PCM1748, PCM1742, and PCM1741 devices, except for pin 5.

Device Information⁽¹⁾

| PART NUMBER | PACKAGE | BODY SIZE (NOM) |
|-------------|-----------|-------------------|
| PCM1753-Q1 | SSOP (16) | 4.90 mm × 3.90 mm |
| PCM1754-Q1 | 330F (16) | 4.90 mm x 3.90 mm |

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Functional Block Diagram





| 1 | Гэ | h | ما | Λf | C_{Δ} | nte | nte |
|---|----|---|----|-----|--------------|-----|------|
| ı | ıa | v | ıe | OI. | CU | HE | 1112 |

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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

| С | hanges from Revision C (October 2012) to Revision D | Page |
|---|---|------|
| • | Changed device temperature grade from 1 to 2 in the Features list | 1 |
| • | Added the ESD Ratings table, Feature Description section, Device Functional Modes section, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section | 1 |
| С | hanges from Revision B (December 2011) to Revision C | Page |
| • | Added AEC-Q100 info to Features | 1 |
| • | Removed DVD Movie Players, DVD Add-On Cards for High-End PCs, and DVD Audio Players from Applications. | 1 |
| • | Added FSD ratings to Abs Max table | 5 |

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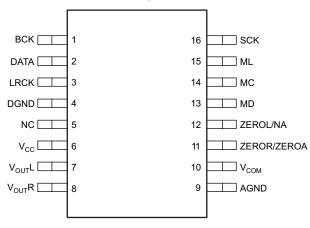


5 Device Comparison Table

| FEATURE | PCM1753-Q1 | PCM1754-Q1 | |
|-----------------------------|---|---|--|
| Audio-data interface format | I ² S, standard, left-justified | I ² S, standard | |
| Audio-data bit length | 16-bit, 18-bit, 20-bit, and 24-bit selectable | 16-bit and 24-bit I ² S, 16-bit standard | |
| Audio data format | MSB first, 2s complement | | |

6 Pin Configuration Functions

PCM1753-Q1 DBQ Package 16-Pin SSOP Top View



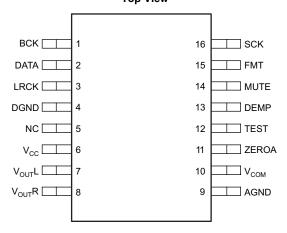
Pin Functions—PCM1753-Q1

| PIN | | 1/0 | DESCRIPTION | |
|--------------------|-----|-----|--|--|
| NAME | NO. | 1/0 | DESCRIPTION | |
| AGND | 9 | _ | Analog ground | |
| BCK | 1 | 1 | Audio-data bit-clock input | |
| DATA | 2 | - 1 | Audio-data digital input | |
| DGND | 4 | I | Digital ground | |
| LRCK | 3 | _ | L-channel and R-channel audio data latch enable input | |
| MC | 14 | I | e control clock input ⁽¹⁾ | |
| MD | 13 | I | ode control data input ⁽¹⁾ | |
| ML | 15 | I | Mode control latch input ⁽¹⁾ | |
| NC | 5 | _ | No connection | |
| SCK | 16 | 1 | System clock input | |
| V_{CC} | 6 | I | Analog power supply, 5 V | |
| V_{COM} | 10 | _ | Common voltage decoupling | |
| V _{OUT} L | 7 | _ | Analog output for the L-channel | |
| V _{OUT} R | 8 | 0 | Analog output for the R-channel | |
| ZEROR/ZEROA | 11 | 0 | Zero flag output for the R-channel. This pin is also the zero flag output for the L-channel and R-channel (2). | |
| ZEROL/NA | 12 | 0 | Zero flag output fo the L-channel. Not assigned (2) | |

- (1) Schmitt-trigger input with internal pulldown
- (2) Open-drain output.



PCM1754-Q1 DBQ Package 16-Pin SSOP Top View



Pin Functions—PCM1754-Q1

| PIN | | 1/0 | DESCRIPTION | |
|--------------------|-----|-----|--|--|
| NAME | NO. | 1/0 | DESCRIPTION | |
| AGND | 9 | _ | Analog ground | |
| BCK | 1 | I | Audio-data bit-clock input | |
| DATA | 2 | I | Audio-data digital input | |
| DEMP | 13 | I | De-emphasis control ⁽¹⁾ | |
| DGND | 4 | _ | Digital ground | |
| FMT | 15 | I | ata format select ⁽¹⁾ | |
| LRCK | 3 | I | -channel and R-channel audio data latch enable input | |
| MUTE | 14 | I | Analog mixing control ⁽¹⁾ | |
| NC | 5 | _ | No connection | |
| SCK | 16 | I | System clock input | |
| TEST | 12 | I | Test pin. Ground or open ⁽¹⁾ | |
| V _{CC} | 6 | _ | Analog power supply, 5 V | |
| V_{COM} | 10 | _ | Common voltage decoupling | |
| V _{OUT} L | 7 | 0 | nalog output for the L-channel | |
| V _{OUT} R | 8 | 0 | Analog output for the R-channel | |
| ZEROA | 11 | 0 | Zero flag output for the L-channel and R-channel | |

(1) Schmitt-trigger input with internal pulldown



7 Specifications

7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

| | | MIN | MAX | UNIT |
|--|-----------------|-------------|-----|------|
| Supply voltage | V _{CC} | -0.3 | 6.5 | V |
| Ground voltage differences | AGND, DGND | -0.1 | 0.1 | V |
| Input voltage | | -0.3 | 6.5 | V |
| Input current (any pins except supplies) | | -10 | 10 | mA |
| Ambient temperature under bias | | -40 | 105 | °C |
| Junction temperature | | | 150 | °C |
| Storage temperature, T _{stg} | | - 55 | 150 | °C |

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

7.2 ESD Ratings

| | | | | VALUE | UNIT |
|--------------------|-------------------------|---------------------------------|-------------------------------|-------|------|
| | | Human body model (HBM), per AEC | Q100-002 ⁽¹⁾ | ±2000 | |
| V _(ESD) | Electrostatic discharge | Charged device model (CDM), per | Corner pins (1, 8, 9, and 16) | ±750 | V |
| | | AEC Q100-011 | Other pins | ±500 | |

⁽¹⁾ AEC Q100-002 indicates HBM stressing is done in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

| | | MIN | NOM | MAX | UNIT |
|----------|---------------|-----|-----|-----|------|
| V_{CC} | Voltage range | 4.5 | 5 | 5.5 | VDC |

7.4 Thermal Information

| | | PCM175x-Q1 | |
|----------------------|--|------------|------|
| | THERMAL METRIC ⁽¹⁾ | DBQ (SSOP) | UNIT |
| | | 16 PINS | |
| $R_{\theta JA}$ | Junction-to-ambient thermal resistance | 111.8 | °C/W |
| $R_{\theta JC(top)}$ | Junction-to-case (top) thermal resistance | 57.4 | °C/W |
| $R_{\theta JB}$ | Junction-to-board thermal resistance | 55.1 | °C/W |
| Ψ_{JT} | Junction-to-top characterization parameter | 13.5 | °C/W |
| ΨЈВ | Junction-to-board characterization parameter | 54.6 | °C/W |
| $R_{\theta JC(bot)}$ | Junction-to-case (bottom) thermal resistance | N/A | °C/W |

For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.

Product Folder Links: PCM1753-Q1 PCM1754-Q1



7.5 Electrical Characteristics

All specifications at $T_A = 25$ °C, $V_{CC} = 5$ V, $f_S = 44.1$ kHz, system clock = 384 f_S , and 24-bit data (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|-----------------|--|---|-----|---|--------------|------|
| | Resolution | | | 24 | | Bits |
| DATA I | FORMAT | | * | | . | |
| f _S | Sampling frequency | | 5 | | 200 | kHz |
| | System clock frequency ⁽¹⁾ | | | 128 f _S 192 f _S 256 f _S 384 f _S 512 f _S 768 f _S 1152 f _S | | kHz |
| DIGITA | L INPUT/OUTPUT | | | | | |
| | Logic family | | | TTL co | mpatible | |
| V_{IH} | Input logic level, high | | 2 | | | VDC |
| V_{IL} | Input logic level, low | | | | 8.0 | VDC |
| I _{IH} | Input logic current, high (SCK, BCK, DATA, and LRCK pins) | $V_{IN} = V_{CC}$ | | | 10 | μΑ |
| I _{IL} | Input logic current, low (SCK, BCK, DATA, and LRCK pins) | V _{IN} = 0 V | | | -10 | μΑ |
| I _{IH} | Input logic current, high (TEST, DEMP, MUTE, and FMT pins) | $V_{IN} = V_{CC}$ | | 65 | 100 | μΑ |
| I _{IL} | Input logic current, low (TEST, DEMP, MUTE, and FMT pins) | V _{IN} = 0 V | | | -10 | μΑ |
| V _{OH} | Output logic level, high (ZEROA pin) | I _{OH} = -1 mA | 2.4 | | | VDC |
| V _{OL} | Output logic level, low (ZEROA pin) | I _{OL} = 1 mA | | | 0.4 | VDC |
| DYNAN | MIC PERFORMANCE (2)(3) | | | | | |
| | | f _S = 44.1 kHz | | 0.00% | 0.01% | |
| | THD+N at VOUT = 0 dB | $f_S = 96 \text{ kHz}$ | | 0.00% | | |
| | | f _S = 192 kHz | | 0.00% | | |
| | | f _S = 44.1 kHz | | 0.65% | | |
| | THD+N at VOUT = -60 dB | $f_S = 96 \text{ kHz}$ | | 0.80% | | |
| | | f _S = 192 kHz | | 0.95% | | |
| | | EIAJ, A-weighted, f _S = 44.1 kHz | 100 | 106 | | |
| | Dynamic range | A-weighted, $f_S = 96 \text{ kHz}$ | | 104 | | dB |
| | | A-weighted, f _S = 192 kHz | | 102 | | |
| | | EIAJ, A-weighted, f _S = 44.1 kHz | 100 | 106 | | |
| | Signal-to-noise ratio | A-weighted, f _S = 96 kHz | | 104 | | dB |
| | | A-weighted, f _S = 192 kHz | | 102 | | |
| | | f _S = 44.1 kHz | 97 | 103 | | |
| | Channel separation | $f_S = 96 \text{ kHz}$ | | 101 | | dB |
| | | f _S = 192 kHz | | 100 | | |
| | Level linearity error | VOUT = -90 dB | | ±0.5 | | dB |

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System Clock: 128 f_S , 192 f_S , 256 f_S , 384 f_S , 512 f_S , 768 f_S , 1152 f_S with auto detect. Analog performance specifications are measured using the System TwoTM Cascade audio measurement system by Audio PrecisionTM in the averaging mode. Conditions in 192-kHz operation are system clock = 128 f_S and oversampling rate = 64 f_S of register 18.



Electrical Characteristics (continued)

All specifications at $T_A = 25$ °C, $V_{CC} = 5$ V, $f_S = 44.1$ kHz, system clock = 384 f_S , and 24-bit data (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|-----------------|-----------------------------------|-----------------------------------|------------------------------|-------|----------------------|-----------------|
| DC ACC | CURACY | · | <u> </u> | | | |
| | Gain error | | | ±1 | ±6 | % of FSR |
| | Gain mismatch, channel-to-channel | | | ±1 | ±3 | % of FSR |
| | Bipolar zero error | VOUT = 0.5 V _{CC} at BPZ | | ±30 | ±60 | mV |
| ANALO | G OUTPUT | | <u>'</u> | | | |
| | Output voltage | Full scale (0 dB) | 80% of V _{CC} | | | V _{PP} |
| | Center voltage | | 50% of V _{CC} | | | VDC |
| | Load impedance | AC-coupled load | 5 | | | kΩ |
| DIGITAL | L FILTER PERFORMANCE | | | | | |
| FILTER | CHARACTERISTICS (SHARP ROLLOFF) | | | | | |
| | Pass band | ±0.04 dB | | | 0.454 f _S | |
| | Stop band | | 0.54 6 fs | | | |
| | Pass-band ripple | | | | ±0.04 | dB |
| | Stop-band attenuation | Stop band = $0.546 f_S$ | -50 | | | dB |
| ANALO | G FILTER PERFORMANCE | | | | | |
| | Frequency response | At 20 kHz | | -0.03 | | dB |
| | r requericy response | At 44 kHz | | -0.20 | | uБ |
| POWER | R SUPPLY REQUIREMENTS(3) | | | | | |
| V_{CC} | Voltage range | | 4.5 | 5 | 5.5 | VDC |
| | | $f_S = 44.1 \text{ kHz}$ | | 16 | 21 | |
| I_{CC} | Supply current | $f_S = 96 \text{ kHz}$ | | 25 | | mA |
| | | $f_S = 192 \text{ kHz}$ | | 30 | | |
| | | $f_S = 44.1 \text{ kHz}$ | | 80 | 105 | |
| | Power dissipation | $f_S = 96 \text{ kHz}$ | | 125 | | mW |
| | | f _S = 192 kHz | | 150 | | |
| TEMPE | RATURE RANGE | | | | | |
| | Operation temperature | | -40 | | 105 | °C |
| $R_{\theta JA}$ | Thermal resistance | 16-pin SSOP | | 115 | | °C/W |

7.6 System Clock Input Timing

For more information, see the *System Clock Input* section.

| | | | MIN | NOM MAX | UNIT |
|---------------------|-----------------------------------|----------------|-----|---------|------|
| t _(SCKH) | System clock pulse duration, high | | 7 | | ns |
| t _(SCKL) | System clock pulse duration, low | See Figure 20. | 7 | | ns |
| t _(SCY) | System clock pulse cycle time | | | See (1) | ns |

(1) $1/128 f_S$, $1/256 f_S$, $1/384 f_S$, $1/512 f_S$, $1/768 f_S$, or $1/1152 f_S$



7.7 Audio Interface Timing

For more information, see the Audio Data Formats and Timing section.

| | | | MIN | MAX | UNIT |
|--------------------|--------------------------------------|----------------|--|-----|------|
| t _(BCY) | BCK pulse cycle time | | 1/(32 f _S) 1/(48 f _S) 1/(64 f _S) | | ns |
| t _(BCH) | BCK high-level time | | 35 | | ns |
| t _(BCL) | BCK low-level time | See Figure 22. | 35 | | ns |
| t _(BL) | BCK rising edge to LRCK edge | | 10 | | ns |
| t _(LB) | LRCK falling edge to BCK rising edge | | 10 | | ns |
| t _(DS) | DATA setup time | | 10 | | ns |
| t _(DH) | DATA hold time | | 10 | | ns |

⁽¹⁾ f_S is the sampling frequency (such as, 44.1 kHz, 48 kHz, 96 kHz, and so on).

7.8 Control Interface Timing Requirements

These timing parameters are critical for proper control port operation.

| | | | MIN | NOM | MAX | UNIT |
|--------------------|-----------------------------------|---------------|---------|-----|-----|------|
| t _(MCY) | MC pulse cycle time | | 100 | | | ns |
| t _(MCL) | MC low-level time | | 50 | | | ns |
| t _(MCH) | MC high-level time | | 50 | | | ns |
| t _(MCH) | ML high-level time | Coo Figure 4 | See (1) | | | ns |
| t _(MLS) | ML falling edge to MC rising edge | See Figure 1. | 20 | | | ns |
| t _(MLH) | ML hold time ⁽²⁾ | | 20 | | | ns |
| t _(MDH) | MD hold time | | 15 | | | ns |
| t _(MDS) | MD setup time | | 20 | | | ns |

3

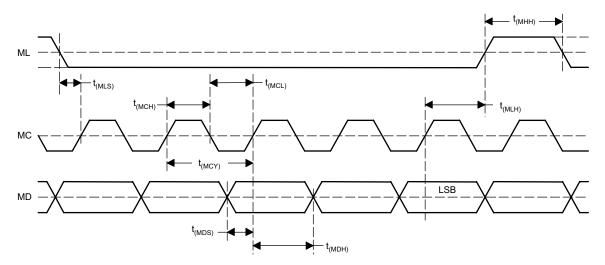


Figure 1. Control Interface Timing

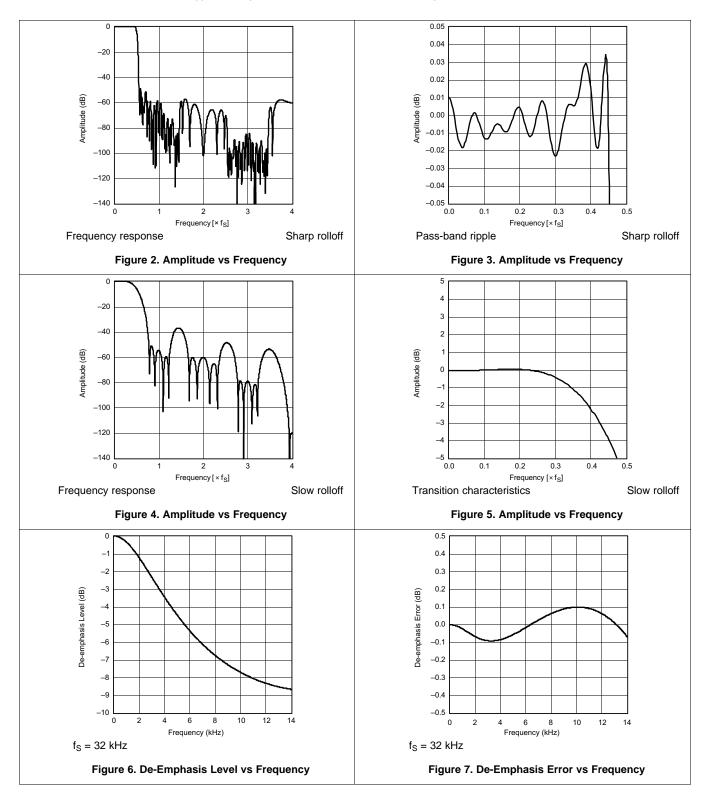
 $[\]begin{tabular}{lll} \hline 256 \times f_S & & \\ \hline & seconds (min); f_S: sampling rate. \\ \hline & MC rising edge for LSB to ML rising edge. \\ \hline \end{tabular}$



7.9 Typical Characteristics

7.9.1 Digital Filter (De-Emphasis Off)

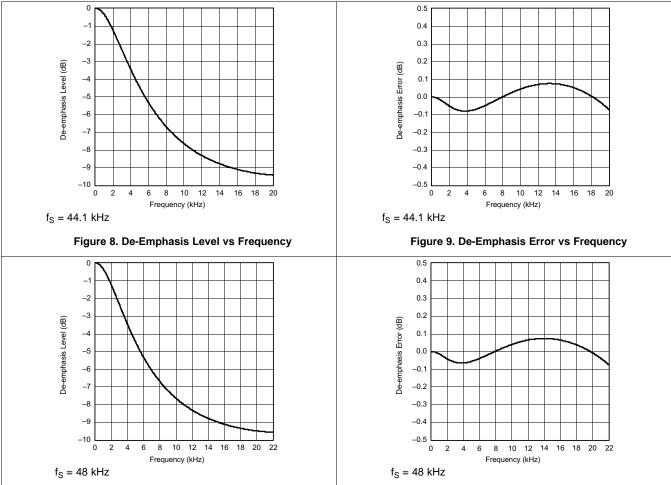
All specifications at $T_A = 25$ °C, $V_{CC} = 5$ V, $f_S = 44.1$ kHz, system clock = 384 f_S , and 24-bit data, (unless otherwise noted)



TEXAS INSTRUMENTS

Digital Filter (De-Emphasis Off) (continued)

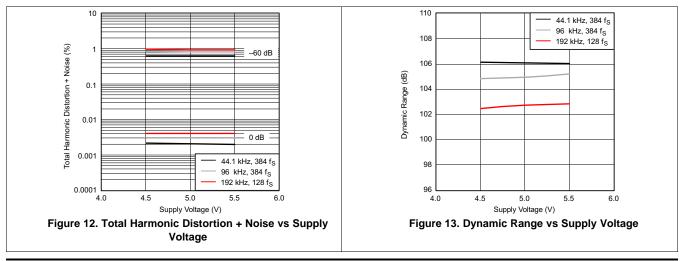
All specifications at $T_A = 25$ °C, $V_{CC} = 5$ V, $f_S = 44.1$ kHz, system clock = 384 f_S , and 24-bit data, (unless otherwise noted)



7.9.2 Analog Dynamic Performance (Supply Voltage Characteristics)

Figure 10. De-Emphasis Level vs Frequency

All specifications at $T_A = 25$ °C, $V_{CC} = 5$ V, $f_S = 44.1$ kHz, system clock = 384 f_S , and 24-bit data, (unless otherwise noted)



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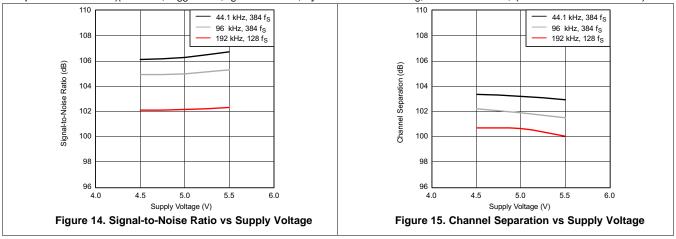
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Figure 11. De-Emphasis Error vs Frequency



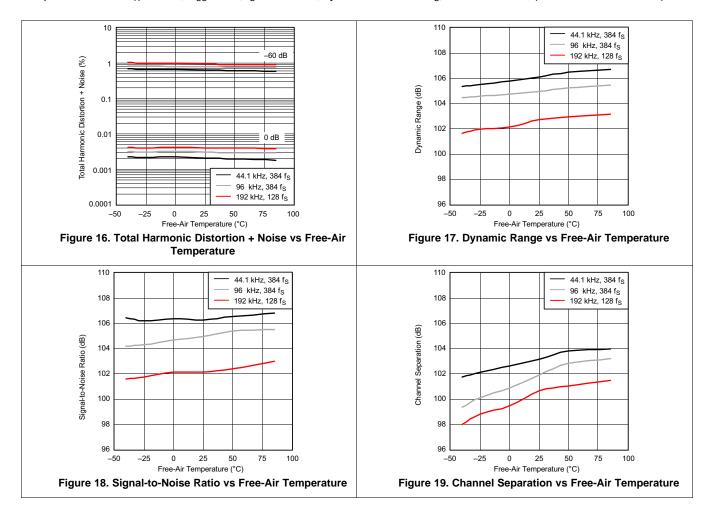
Analog Dynamic Performance (Supply Voltage Characteristics) (continued)

All specifications at $T_A = 25$ °C, $V_{CC} = 5$ V, $f_S = 44.1$ kHz, system clock = 384 f_S , and 24-bit data, (unless otherwise noted)



7.9.3 Analog Dynamic Performance (Temperature Characteristics)

All specifications at $T_A = 25$ °C, $V_{CC} = 5$ V, $f_S = 44.1$ kHz, system clock = 384 f_S , and 24-bit data, (unless otherwise noted)



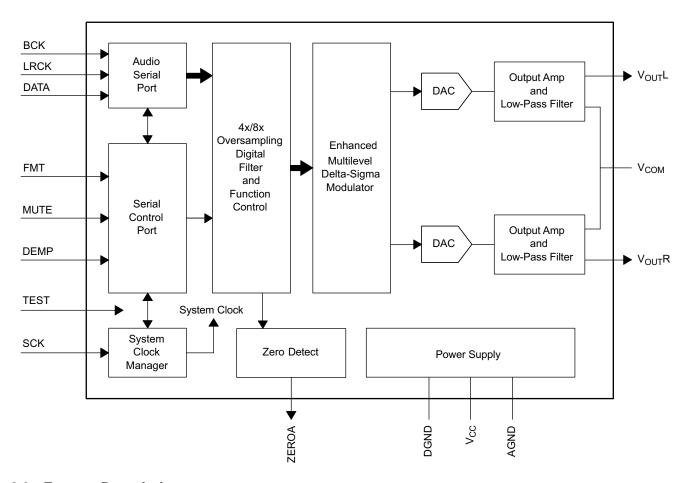


8 Detailed Description

8.1 Overview

The PCM175x-Q1 family of devices are stereo digital-to-analog converters (DACs) based on TI's enhanced delta-sigma architecture which employs 4th-order noise shaping and 8-level amplitude quantization to achieve excellent dynamic performance and improved clock jitter tolerance. The PCM175x-Q1 family of devices easily interface with an audio DSP and decoder chips because of the device supports industry-standard audio data formats with 16- and 24-bit data. The PCM1754-Q1 device also offers hardware control.

8.2 Functional Block Diagram



8.3 Feature Description

8.3.1 System Clock and Reset Functions

8.3.1.1 System Clock Input

The PCM175x-Q1 family of devices requires a system clock for operating the digital interpolation filters and multilevel delta-sigma modulators. The system clock is applied at the SCK input (pin 16). Table 1 lists examples of system clock frequencies for common audio sampling rates.

Figure 20 shows and the *System Clock Input Timing* table lists the timing requirements for the system clock input. For optimal performance, use a clock source with low phase-jitter and noise. Tl's PLL170x family of multiclock generators is an excellent choice for providing the PCM175x-Q1 system clock.

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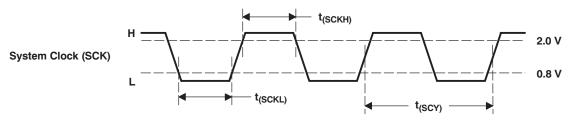


Feature Description (continued)

Table 1. System Clock Rates for Common Audio Sampling Frequencies

| SAMPLING | | SYSTEM CLOCK FREQUENCY (f _{SCLK}) (MHz) | | | | | | | | | | | |
|-----------|--------------------|---|--------------------|--------------------|--------------------|--------------------|---------------------|--|--|--|--|--|--|
| FREQUENCY | 128 f _S | 192 f _S | 256 f _S | 384 f _S | 512 f _S | 768 f _S | 1152 f _S | | | | | | |
| 8 kHz | 1.024 | 1.536 | 2.048 | 3.072 | 4.096 | 6.144 | 9.216 | | | | | | |
| 16 kHz | 2.048 | 3.072 | 4.096 | 6.144 | 8.192 | 12.288 | 18.432 | | | | | | |
| 32 kHz | 4.096 | 6.144 | 8.192 | 12.288 | 16.384 | 24.576 | 36.864 | | | | | | |
| 44.1 kHz | 5.6448 | 8.4672 | 11.2896 | 16.9344 | 22.5792 | 33.8688 | See (1) | | | | | | |
| 48 kHz | 6.144 | 9.216 | 12.288 | 18.432 | 24.576 | 36.864 | See (1) | | | | | | |
| 88.2 kHz | 11.2896 | 16.9344 | 22.5792 | 33.8688 | 45.1584 | See (1) | See (1) | | | | | | |
| 96 kHz | 12.288 | 18.432 | 24.576 | 36.864 | 49.152 | See (1) | See (1) | | | | | | |
| 192 kHz | 24.576 | 36.864 | See (1) | | | | | | |

(1) This system clock rate is not supported for the given sampling frequency.



For timing specifications, see the System Clock Input Timing table.

Figure 20. System Clock Input Timing

8.3.1.2 Power-On Reset Functions

The PCM175x-Q1 family of devices includes a power-on reset function. Figure 21 shows the operation of this function. With the system clock active and $V_{CC} > 3$ V (typical, 2.2 V to 3.7 V), the power-on reset function is enabled. The initialization sequence requires 1024 system clocks from the time $V_{CC} > 3$ V (typical, 2.2 V to 3.7 V).

During the reset period (1024 system clocks), the analog output is forced to the bipolar zero level, or V_{CC} / 2. After the reset period, an internal register is initialized in the next 1 / f_S period and if SCK, BCK, and LRCK are provided continuously, the PCM175x-Q1 family of devices provides proper analog output with unit group delay against the input data.

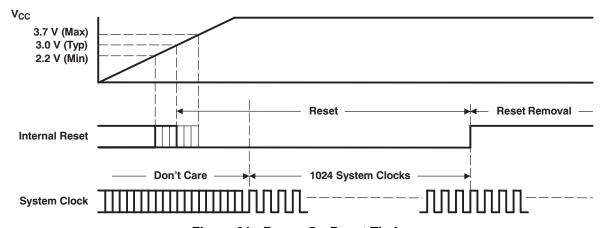


Figure 21. Power-On Reset Timing



8.3.2 Audio Serial Interface

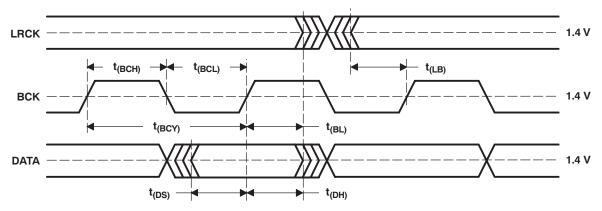
The audio serial interface for the PCM175x-Q1 family of devices consists of a 3-wire synchronous serial port. The interface includes LRCK (pin 3), BCK (pin 1), and DATA (pin 2). The BCK pin is the serial audio bit clock, and is used to clock the serial data present on the DATA pin into the serial shift register of the audio interface. Serial data is clocked into the PCM175x-Q1 family of devices on the rising edge of BCK. The LRCK pin is the serial audio left and right word clock. This pin is used to latch serial data into the internal registers of the serial audio interface.

Both the LRCK and BCK pins should be synchronous to the system clock. Ideally, TI recommends that the LRCK and BCK pins be derived from the system clock input, SCK. The LRCK pin is operated at the sampling frequency, f_S. The BCK pin can operate at 32, 48, or 64 times the sampling frequency for standard (right-justified) format, and 32 times the sampling frequency of the BCK pin is limited to 16-bit right-justified format only. The BCK pin can operate at 48 or 64 times the sampling frequency for the I²S and left-justified formats, and 48 times the sampling frequency of the BCK pin is limited to 192, 384, and 768 f_S SCKI.

Internal operation of the PCM175x-Q1 family of devices is synchronized with the LRCK pin. Accordingly, internal operation is held when the sampling rate clock of the LRCK pin changes or when the SCK pin, BCK pin, or both pins are interrupted for a 3-bit clock cycle or longer. If the SCK, BCK, and LRCK pins are provided continuously after this held condition, the internal operation is re-synchronized automatically in a period of less than 3 / f_S . External resetting is not required.

8.3.2.1 Audio Data Formats and Timing

The PCM1753-Q1 device supports industry-standard audio data formats, including right-justified, I²S, and left-justified. The PCM1754-Q1 device supports I²S and 16-bit-word right-justified audio data formats. Figure 23 shows the data formats. Data formats are selected using the format bits, FMT[2:0], located in control register 20 of the PCM1753-Q1 device, and are selected using the FMT pin on the PCM1754-Q1 device. The default data format is 24-bit left-justified. All formats require binary 2s-complement MSB-first audio data. Figure 22 shows a detailed timing diagram for the serial audio interface. The *Audio Interface Timing* table lists the audio interface timing requirements.

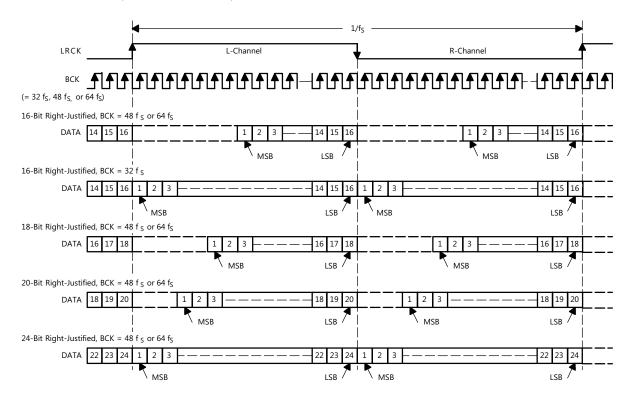


For timing specifications, see the Audio Interface Timing table.

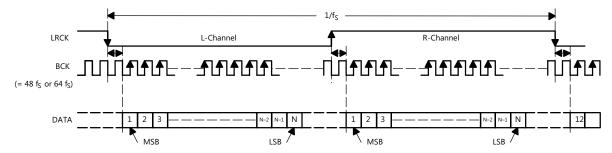
Figure 22. Audio Interface Timing



(1) Standard Data Format; L-Channel = HIGH, R-Channel = LOW



(2) I²S Data Format; L-Channel = LOW, R-Channel = HIGH



(3) Left-Justified Data Format; L-Channel = HIGH, R-Channel = LOW

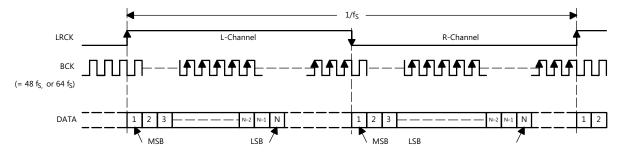


Figure 23. Audio Data Input Formats



8.3.3 Zero Flag (PCM1754-Q1)

The PCM1754-Q1 device has a ZERO flag pin, ZEROA (pin 11). The ZEROA pin is the L-channel and R-channel common zero flag pin. If the data for L-channel and R-channel remains at a 0 level for 1024 sampling periods (or LRCK clock periods), the ZEROA pin is set to a logic 1 state.

8.3.4 Zero Flag (PCM1753-Q1)

Zero-Detect Condition

Zero detection for either output channel is independent from the other channel. If the data for a given channel remains at a 0 level for 1024 sample periods (or LRCK clock periods), a zero-detect condition exists for that channel.

8.3.5 Zero Flag Outputs

If a zero-detect condition exists for one or more channels, the zero flag pins for those channels are set to a logic 1 state. Each channel has zero flag pins, ZEROL (pin 12) and ZEROR (pin 11). These pins can operate external mute circuits, or used as status indicators for a microcontroller, audio signal processor, or other digitally controlled function. The active polarity of the zero flag outputs can be inverted by setting the ZREV bit of control register 22 to 1. The reset default is active-high output, or ZREV set to 0. The L-channel and R-channel common zero flag can be selected by setting the AZRO bit of control register 22 to 1. The reset default is independent zero flags for L-channel and R-channel, or AZRO set to 0.

8.3.6 Analog Outputs

The PCM1753-Q1 device includes two independent output channels, $V_{OUT}L$ and $V_{OUT}R$. These are unbalanced outputs, each capable of driving 4 V_{PP} typical into a 5-k Ω ac-coupled load. The internal output amplifiers for $V_{OUT}L$ and $V_{OUT}R$ are biased to the dc common-mode (or bipolar zero) voltage, equal to 0.5 V_{CC} .

The output amplifiers include an RC continuous-time filter, which helps to reduce the out-of-band noise energy present at the DAC outputs due to the noise shaping characteristics of the PCM1754-Q1 delta-sigma DAC. The frequency response of this filter is shown in Figure 24. By itself, this filter is not enough to attenuate the out-of-band noise to an acceptable level for many applications. An external low-pass filter is required to provide sufficient out-of-band noise rejection. Further discussion of DAC post-filter circuits is provided in the Applications Information section of this data sheet.

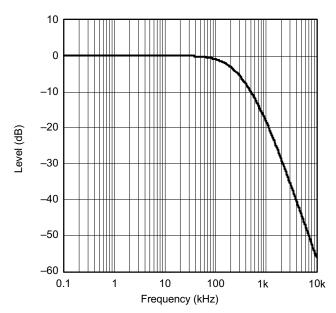


Figure 24. Level vs Frequency Output Filter Frequency Response

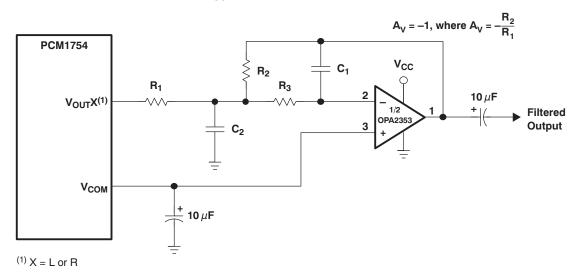
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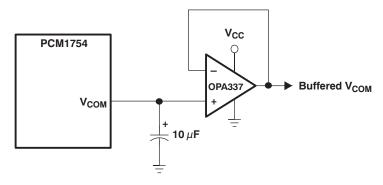


8.3.6.1 V_{COM} Output

One unbuffered common-mode voltage output pin, V_{COM} (pin 10) is brought out for decoupling purposes. This pin is nominally biased to a DC-voltage level that is equal to 0.5 V_{CC} . This pin can be used to bias external circuits. Figure 25 shows an example of using the V_{COM} pin for external biasing applications.



(a) Using V_{COM} to Bias a Single-Supply Filter Stage



(b) Using a Voltage Follower to Buffer V_{COM} When Biasing Multiple Nodes

Figure 25. Biasing External Circuits Using the V_{COM} Pin

8.4 Device Functional Modes

8.4.1 Hardware Control (PCM1754-Q1)

The digital functions of the PCM1754-Q1 device are capable of hardware control. Table 2 lists selectable formats, Table 3 lists de-emphasis control, and Table 4 lists mute control.

Table 2. Data Format Select

| FMT (PIN 15) | DATA FORMAT |
|--------------|--|
| LOW | 16- to 24-bit, I ² S format |
| HIGH | 16-bit right-justified |

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Table 3. De-Emphasis Control

| DEMP (PIN 13) | DE-EMPHASIS FUNCTION |
|---------------|--------------------------|
| LOW | 44.1 kHz de-emphasis OFF |
| HIGH | 44.1 kHz de-emphasis ON |

Table 4. Mute Control

| MUTE (PIN 14) | MUTE |
|---------------|----------|
| LOW | Mute OFF |
| HIGH | Mute ON |

8.4.2 Oversampling Rate Control (PCM1754-Q1)

The PCM1754-Q1 device automatically controls the oversampling rate of the delta-sigma DACs with the system clock rate. The oversampling rate is set to 64× oversampling with every system clock and sampling frequency.

8.5 Programming

8.5.1 Software Control (PCM1753-Q1)

The PCM1753-Q1 device has many programmable functions which can be controlled in the software control mode. The functions are controlled by programming the internal registers using ML, MC, and MD.

The serial control interface is a 3-wire serial port, which operates asynchronously to the audio serial interface. The serial control interface is used to program the on-chip mode registers. The control interface includes the MD (pin 13), MC (pin 14), and ML (pin 15) pins. The MD pin is the serial data input, used to program the mode registers. The MC pin is the serial bit clock, used to shift data into the control port. The ML pin is the control port latch clock.

8.5.1.1 Register Write Operation

All write operations for the serial control port use 16-bit data words. Figure 26 shows the control data word format. The most significant bit must be a 0. There are seven bits, labeled IDX[6:0], that set the register index (or address) for the write operation. The least significant eight bits, D[7:0], contain the data to be written to the register specified by IDX[6:0].

Figure 27 shows the functional timing diagram for writing to the serial control port. ML is held at a logic 1 state until a register needs to be written. To begin the register write cycle, ML is set to logic 0. Sixteen clocks are then provided on the MC pin, corresponding to the 16 bits of the control data word on MD. After the sixteenth clock cycle has completed, ML is set to logic 1 to latch the data into the indexed mode control register.



Figure 26. Control Data Word Format for MD

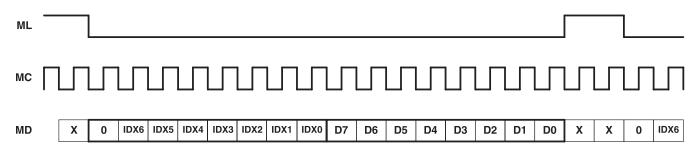


Figure 27. Register Write Operation

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8.6 Register Maps

8.6.1 Mode Control Registers (PCM1753-Q1)

8.6.1.1 User-Programmable Mode Controls

The PCM1753-Q1 device includes a number of user programmable functions, which are accessed through control registers. The registers are programmed using the serial control interface, which was previously discussed in this data sheet. Table 5 lists the available mode control functions, along with the corresponding reset default conditions and associated register index.

Table 5. User-Programmable Mode Controls

| FUNCTION | RESET DEFAULT | REGISTER | BIT(s) |
|--|--------------------------------|-----------|--------------------|
| Digital attenuation control, 0 dB to -63 dB in 0.5-dB steps | 0 dB, no attenuation | 16 and 17 | AT1[7:0], AT2[7:0] |
| Soft mute control | Mute disabled | 18 | MUT[2:0] |
| Oversampling rate control (64 f _S or 128 f _S) | 64 f _S oversampling | 18 | OVER |
| Soft reset control | Reset disabled | 18 | SRST |
| DAC operation control | DAC1 and DAC2 enabled | 19 | DAC[2:1] |
| De-emphasis function control | De-emphasis disabled | 19 | DM12 |
| De-emphasis sample rate selection | 44.1 kHz | 19 | DMF[1:0] |
| Audio data format control | 24-bit left-justified | 20 | FMT[2:0] |
| Digital filter rolloff control | Sharp rolloff | 20 | FLT |
| Zero flag function select | L-, R-channel independent | 22 | AZRO |
| Output phase select | Normal phase | 22 | DREV |
| Zero flag polarity select | High | 22 | ZREV |

The mode control register map is shown in Table 6. Each register includes an index (or address) indicated by the IDX[6:0] bits.

Table 6. Mode Control Register Map⁽¹⁾

| IDX (B8-B 14) | REGISTER | B15 | B14 | B13 | B12 | B11 | B10 | В9 | В8 | В7 | В6 | В5 | В4 | В3 | B2 | B1 | В0 |
|---------------------|-------------|-----|------|------|------|------|------|------|------|------|------|------|------|------|------|------|------|
| 10h | Register 16 | 0 | IDX6 | IDX5 | IDX4 | IDX3 | IDX2 | IDX1 | IDX0 | AT17 | AT16 | AT15 | AT14 | AT13 | AT12 | AT11 | AT10 |
| 11h | Register 17 | 0 | IDX6 | IDX5 | IDX4 | IDX3 | IDX2 | IDX1 | IDX0 | AT27 | AT26 | AT25 | AT24 | AT23 | AT22 | AT21 | AT20 |
| 12h | Register 18 | 0 | IDX6 | IDX5 | IDX4 | IDX3 | IDX2 | IDX1 | IDX0 | SRST | OVER | RSV | RSV | RSV | RSV | MUT2 | MUT1 |
| 13h | Register 19 | 0 | IDX6 | IDX5 | IDX4 | IDX3 | IDX2 | IDX1 | IDX0 | RSV | DMF1 | DMF0 | DM12 | RSV | RSV | DAC2 | DAC1 |
| 14h | Register 20 | 0 | IDX6 | IDX5 | IDX4 | IDX3 | IDX2 | IDX1 | IDX0 | RSV | RSV | FLT | RSV | RSV | FMT2 | FMT1 | FMT0 |
| 16h | Register 22 | 0 | IDX6 | IDX5 | IDX4 | IDX3 | IDX2 | IDX1 | IDX0 | RSV | RSV | RSV | RSV | RSV | AZRO | ZREV | DREV |

(1) RSV: Reserved for test operation. It should be set to 0 for regular operation.



8.6.1.2 Register Definitions

| | B15 | B14 | B13 | B12 | B11 | B10 | В9 | B8 | В7 | В6 | B5 | В4 | В3 | B2 | B1 | В0 |
|-------------|-----|------|------|------|------|------|------|------|------|------|------|------|------|------|------|------|
| Register 16 | 0 | IDX6 | IDX5 | IDX4 | IDX3 | IDX2 | IDX1 | IDX0 | AT17 | AT16 | AT15 | AT14 | AT13 | AT12 | AT11 | AT10 |
| · | | | | | | | | | | | | | | | | |
| | B15 | B14 | B13 | B12 | B11 | B10 | В9 | В8 | В7 | В6 | B5 | В4 | В3 | B2 | B1 | В0 |
| Register 17 | 0 | IDX6 | IDX5 | IDX4 | IDX3 | IDX2 | IDX1 | IDX0 | AT27 | AT26 | AT25 | AT24 | AT23 | AT22 | AT21 | AT20 |

8.6.1.2.1 ATx[7:0]: Digital Attenuation Level Setting

With x = 1 or 2, corresponding to the DAC output $V_{OUT}L$ (x = 1) and $V_{OUT}R$ (x = 2).

Default value: 1111 1111b

Each DAC channel (V_{OUT}L and V_{OUT}R) includes a digital attenuation function. The attenuation level can be set from 0 dB to -63 dB in 0.5-dB steps. Changes in attenuator levels are made by incrementing or decrementing one step (0.5 dB) for every 8/fS time internal until the programmed attenuator setting is reached. Alternatively, the attenuation level can be set to infinite attenuation (or mute).

The attenuation data for each channel can be set individually. The attenuation level is set using Equation 1. Attenuation level (dB) = $0.5 \times (ATx[7:0]_{DEC} - 255)$

where

For ATx[7:0]DEC = 0 through 128, attenuation is set to infinite attenuation.

The table in Figure 28 shows the attenuation levels for various settings.

| ATx[7:0] | DECIMAL VALUE | ATTENUATION LEVEL SETTING | | | | | | | | | | | |
|------------------------|----------------|---------------------------|---------------------------------|----|----|----------|------|----|----------|----|----|--|--|
| 1111 1111b | 255 | | 0 dB, No Attenuation. (default) | | | | | | | | | | |
| 1111 1110b | 254 | | –0.5 dB | | | | | | | | | | |
| 1111 1101b | 253 | | −1.0 dB | | | | | | | | | | |
| : | : | | | | | | | | | | | | |
| 1000 0011b | 131 | −62.0 dB | | | | | | | -62.0 dB | | | | |
| 1000 0010b | 130 | | | | | -62.5 dB | | | | | | | |
| 1000 0001b | 129 | | | | | -63.0 |) dB | | | | | | |
| 1000 0000b | 128 | | | | | Mu | te | | | | | | |
| : | : : | | | | | | | | | | | | |
| 0000 0000 _B | 0 | Mute | | | | | | | | | | | |
| B15 B14 B | 13 B12 B11 B10 | В9 | B8 | B7 | В6 | B5 | В4 | В3 | B2 | B1 | В0 | | |

Register 18 IDX6 | IDX5 | IDX4 | IDX3 | IDX2 IDX1 | IDX0 | SRST | OVER | RSV RSV

Figure 28. Attenuation Level Settings

8.6.1.2.2 MUTx: Soft Mute Control

With x = 1 or 2, corresponding to the DAC outputs $V_{OUT}L$ (x = 1) and $V_{OUT}R$ (x = 2).

Default value: 0

| MUTx = 0 | Mute disabled (default) |
|----------|-------------------------|
| MUTx = 1 | Mute enabled |



The mute bits, MUT1 and MUT2, are used to enable or disable the soft mute function for the corresponding DAC outputs, VOUTL and VOUTR. The soft mute function is incorporated into the digital attenuators. When mute is disabled (MUTx = 0), the attenuator and DAC operate normally. When mute is enabled by setting MUTx = 1, the digital attenuator for the corresponding output is decreased from the current setting to infinite attenuation, one attenuator step (0.5 dB) for every 8 / f_s seconds. This provides pop-free muting of the DAC output.

By setting MUTx = 0, the attenuator is increased one step for every $8/f_S$ seconds to the previously programmed attenuation level.

8.6.1.2.3 OVER: Oversampling Rate Control

Default value: 0

System clock rate = 256 f_S , 384 f_S , 512 f_S , 768 f_S , or 1152 f_S :

| OVER = 0 | 64· oversampling (default) |
|----------|----------------------------|
| OVER = 1 | 128 oversampling |

System clock rate = $128 f_S$ or $192 f_S$:

| OVER = 0 | 32· oversampling (default) |
|----------|----------------------------|
| OVER = 1 | 64. oversampling |

The OVER bit is used to control the oversampling rate of the delta-sigma DAC. The OVER = 1 setting is recommended when the sampling rate is 192 kHz (system clock rate is 128 f_S or 192 f_S).

8.6.1.2.4 SRST: Reset

Default value: 0

| SRST = 0 | Reset disabled (default) |
|----------|--------------------------|
| SRST = 1 | Reset enabled |

The SRST bit is used to enable or disable the soft reset function. The operation is the same as power-on reset. All registers are initialized.

| | B15 | B14 | B13 | B12 | B11 | B10 | В9 | B8 | B7 | B6 | B5 | B4 | В3 | B2 | B1 | В0 |
|-------------|-----|------|------|------|------|------|------|------|-----|------|------|------|-----|-----|------|------|
| Register 19 | 0 | IDX6 | IDX5 | IDX4 | IDX3 | IDX2 | IDX1 | IDX0 | RSV | DMF1 | DMF0 | DM12 | RSV | RSV | DAC2 | DAC1 |

8.6.1.2.5 DACx: DAC Operation Control

With x = 1 or 2, corresponding to the DAC output $V_{OUT}L$ (x = 1) or $V_{OUT}R$ (x = 2).

Default value: 0

| DACx = 0 | DAC operation enabled (default) |
|----------|---------------------------------|
| DACx = 1 | DAC operation disabled |

The DAC operation controls are used to enable and disable the DAC outputs, $V_{OUT}L$ and $V_{OUT}R$. When DACx = 0, the corresponding output generates the audio waveform dictated by the data present on the DATA pin. When DACx = 1, the corresponding output is set to the bipolar zero level, or 0.5 V_{CC} .

8.6.1.2.6 DM12: Digital De-Emphasis Function Control

Default value: 0

| DM12 = 0 | De-emphasis disabled (default) |
|----------|--------------------------------|
| DM12 = 1 | De-emphasis enabled |



The DM12 bit is used to enable or disable the digital de-emphasis function. See the plots shown in the *Typical Characteristics* section of this data sheet.

8.6.1.2.7 DMF[1:0]: Sampling Frequency Selection for the De-Emphasis Function

Default value: 00

The DMF[1:0] bits are used to select the sampling frequency used for the digital de-emphasis function when it is enabled.

| DMF[1:0] | De-Emphasis Sample Rate Selection |
|----------|-----------------------------------|
| 00 | 44.1 kHz (default) |
| 01 | 48 kHz |
| 10 | 32 kHz |
| 11 | Reserved |

| | B15 | B14 | B13 | B12 | B11 | B10 | B9 | B8 | B7 | B6 | B5 | B4 | В3 | B2 | B1 | B0 |
|-------------|-----|------|------|------|------|------|------|------|-----|-----|-----|-----|-----|------|------|------|
| Register 20 | 0 | IDX6 | IDX5 | IDX4 | IDX3 | IDX2 | IDX1 | IDX0 | RSV | RSV | FLT | RSV | RSV | FMT2 | FMT1 | FMT0 |

8.6.1.2.8 FMT[2:0]: Audio Interface Data Format

Default value: 101

The FMT[2:0] bits are used to select the data format for the serial audio interface. The table in Figure 29 shows the available format options.

| FMT[2:0] | Audio Data Format Selection |
|----------|---|
| 000 | 24-bit standard format, right-justified data |
| 001 | 20-bit standard format, right-justified data |
| 010 | 18-bit standard format, right-justified data |
| 011 | 16-bit standard format, right-justified data |
| 100 | 16- to 24-bit I ² S format |
| 101 | 16- to 24-bit left-justified format (default) |
| 110 | Reserved |
| 111 | Reserved |

Figure 29. Audio Data Format Options

8.6.1.2.9 FLT: Digital Filter Rolloff Control

Default value: 0

| FLT = 0 | Sharp rolloff (default) |
|---------|-------------------------|
| FLT = 1 | Slow rolloff |

The FLT bit allows the user to select the digital filter rolloff that is best suited to the application. Two filter rolloff selections are available, sharp and slow. The filter responses for these selections are shown in the *Typical Characteristics* section of this data sheet.

| | B15 | B14 | B13 | B12 | B11 | B10 | B9 | B8 | B7 | B6 | B5 | B4 | В3 | B2 | B1 | B0 |
|-------------|-----|------|------|------|------|------|------|------|-----|-----|-----|-----|-----|------|------|------|
| Register 22 | 0 | IDX6 | IDX5 | IDX4 | IDX3 | IDX2 | IDX1 | IDX0 | RSV | RSV | RSV | RSV | RSV | AZRO | ZREV | DREV |

Product Folder Links: PCM1753-Q1 PCM1754-Q1





8.6.1.2.10 DREV: Output Phase Select

Default value: 0

| DREV = 0 | Normal output (default) |
|----------|-------------------------|
| DREV = 1 | Inverted output |

The DREV bit is the output analog signal phase control.

8.6.1.2.11 ZREV: Zero Flag Polarity Select

Default value: 01h

| ZREV = 0 | High on zero flag pins indicates a zero detect (default) |
|----------|--|
| ZREV = 1 | Low on zero flag pins indicates a zero detect |

The ZREV bit allows the user to select the polarity of zero flag pins.

8.6.1.2.12 AZRO: Zero Flag Function Select

Default value: 0

| AZRO = 0 | L-/R-channel independent zero flags (default) |
|----------|---|
| AZRO = 1 | L-/R-channel common zero flag |

The AZRO bit allows the user to select the function of zero flag pins.

| AZRO = 0: | Pin 11: ZEROR, zero flag output for R-channel |
|-----------|---|
| | Pin 12: ZEROL, zero flag output for L-channel |
| AZRO = 1: | Pin 11: ZEROA, zero flag output for L-/R-channels |
| | Pin 12: NA, not assigned |



9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

The delta-sigma section of the PCM175x-Q1 family of devices is based on an 8-level amplitude quantizer and a 4th-order noise shaper. This section converts the oversampled input data to 8-level delta-sigma format. Figure 32 shows a block diagram of the 8-level delta-sigma modulator. This 8-level delta-sigma modulator has the advantage of stability and clock jitter sensitivity over the typical one-bit (2-level) delta-sigma modulator.

The combined oversampling rate of the delta-sigma modulator and the interpolation filter is 64 fs.

Figure 35 and Figure 36 show the theoretical quantization noise performance of the 8-level delta-sigma modulator. The enhanced multilevel delta-sigma architecture also has advantages for input clock jitter sensitivity because of the multilevel quantizer, with the simulated jitter sensitivity shown in Figure 37.

9.2 Typical Application

Figure 30 shows a basic connection diagram with the necessary power supply bypassing and decoupling components. TI recommends using the component values shown in Figure 30 for all designs.

The use of series resistors (22 Ω to 100 Ω) is recommended for the SCK, LRCK, BCK, and DATA inputs. The series resistor combines with the stray PCB and device input capacitance to form a low-pass filter, which reduces high-frequency noise emissions and helps to dampen glitches and ringing present on clock and data lines.

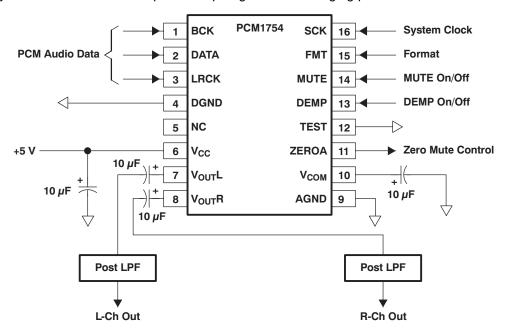


Figure 30. Basic Connection Diagram



9.2.1 Design Requirements

9.2.1.1 Power Supplies and Grounding

The PCM1754-Q1 device requires 5 V for V_{CC}.

Proper power supply bypassing is shown in Figure 30. The 10-μF capacitors should be tantalum or aluminum electrolytic.

9.2.1.2 DAC Output Filter Circuits

Delta-sigma DAC use noise-shaping techniques to improve in-band signal-to-noise ratio (SNR) performance at the expense of generating increased out-of-band noise above the Nyquist frequency, or $f_{\rm S}$ / 2. The out-of-band noise must be low-pass filtered in order to provide the optimal converter performance which is accomplished by a combination of on-chip and external low-pass filtering.

Figure 25(a) and Figure 31 show the recommended external low-pass active filter circuits for single- and dual-supply applications. These circuits are second-order Butterworth filters using the multiple feedback (MFB) circuit arrangement, which reduces sensitivity to passive component variations over frequency and temperature. For more information regarding MFB active filter design, see the Burr-Brown application bulletin, *Dynamic Performance Testing of Digital audio D/A Converters* (SBAA055).

Because the overall system performance is defined by the quality of the DAC and the associated analog output circuitry, high-quality audio operational amplifiers are recommended for the active filters. Tl's OPA2353 and OPA2134 dual operational amplifiers are shown in Figure 25(a) and Figure 31, and are recommended for use with the PCM1754-Q1 device.

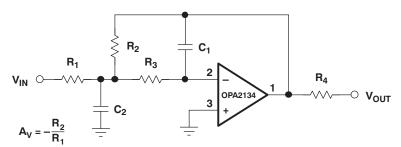


Figure 31. Dual-Supply Filter Circuit

9.2.2 Detailed Design Procedure

This section provides information on how to measure key dynamic performance parameters for the PCM175x-Q1 family of devices. In all cases, an Audio Precision System Two Cascade audio measurement system or equivalent is used to perform the testing.

9.2.2.1 Total Harmonic Distortion + Noise

Total harmonic distortion + noise (THD+N) is a significant figure of merit for audio DAC because it takes into account both harmonic distortion and all noise sources within a specified measurement bandwidth. The average value of the distortion and noise is referred to as THD+N.

For the PCM175x-Q1 family of devices, THD+N is measured with a full-scale, 1-kHz digital sine wave as the test stimulus at the input of the DAC (see Figure 33). The digital generator is set to 24-bit audio word length and a sampling frequency of 44.1 kHz or 96 kHz. The digital generator output is taken from the unbalanced S/PDIF connector of the measurement system. The S/PDIF data is transmitted through a coaxial cable to the digital audio receiver on the DEM-DAI1753 demonstration board. The receiver is then configured to output 24-bit data in either I²S or left-justified data format. The DAC audio interface format is programmed to match the receiver output format. The analog output is then taken from the DAC post filter and connected to the analog analyzer input of the measurement system. The analog input is band limited using filters resident in the analyzer. The resulting THD+N is measured by the analyzer and displayed by the measurement system.

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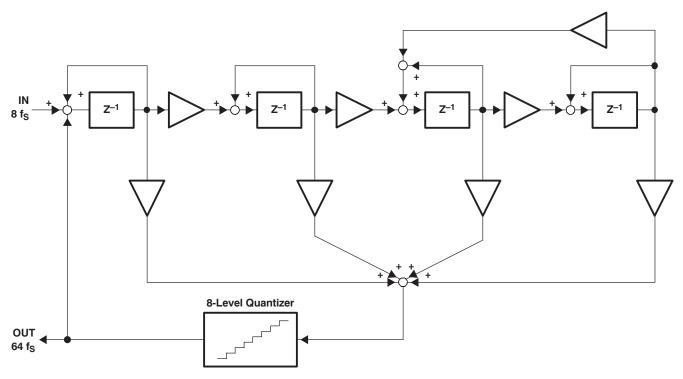


Figure 32. Eight-Level Delta-Sigma Modulator

9.2.2.2 Dynamic Range

Dynamic range is specified as A-weighted THD+N measured with a -60-dB full-scale, 1-kHz digital sine wave stimulus at the input of the DAC. This measurement is designed to give a good indicator of how the DAC performs given a low-level input signal.

The measurement setup for the dynamic range measurement is shown in Figure 34, and is similar to the THD+N test setup discussed previously. The differences include the band limit filter selection, the additional A-weighting filter, and the –60-dB full-scale input level.



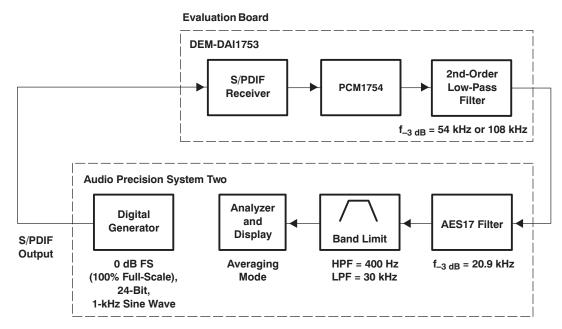


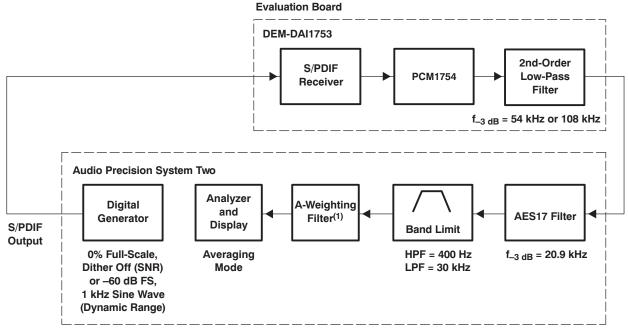
Figure 33. Test Setup for THD+N Measurement

9.2.2.3 Idle Channel Signal-to-Noise Ratio (SNR)

The SNR test provides a measure of the noise floor of the DAC. The input to the DAC is all–0s data, and the dither function of the digital generator must be disabled to ensure an all–0s data stream at the input of the DAC.

The measurement setup for SNR is identical to that used for dynamic range, with the exception of the input signal level.

See the note provided in Figure 34.

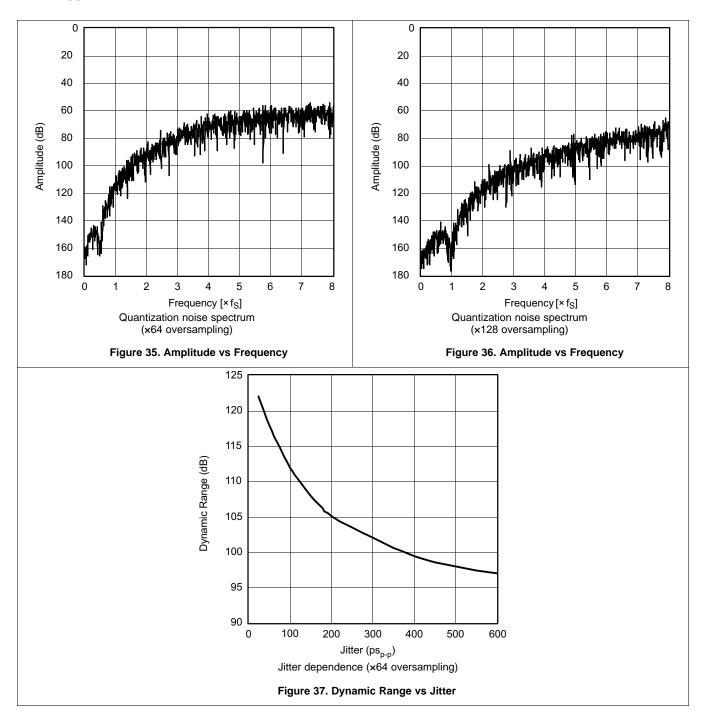


⁽¹⁾ Results without A-Weighting are approximately 3 dB worse.

Figure 34. Test Setup for Dynamic Range and SNR Measurement



9.2.3 Application Curves



Submit Documentation Feedback

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10 Power Supply Recommendations

The PCM175x-Q1 family of devices is designed to operate from a power supply from 4.5 V to 5.5 V. Ensure that the power supply is clean and use high-quality decoupling capacitors to reduce noise. The bulk capacitances can be from either tantalum or aluminum capacitors.

Separate power supplies are recommended for the digital and analog sections of the board. This prevents the switching noise present on the digital supply from contaminating the analog power supply and degrading the dynamic performance of the PCM175x-Q1 family of devices. In cases where a common 5-V supply must be used for the analog and digital sections, an inductance (RF choke, ferrite bead) should be placed between the analog and digital 5-V supply connections to avoid coupling of the digital switching noise into the analog circuitry. Figure 39 shows the recommended approach for single-supply applications.

11 Layout

11.1 Layout Guidelines

Figure 38 shows a typical PCB floor plan for the PCM175x-Q1 family of devices. A ground plane is recommended, with the analog and digital sections being isolated from one another using a split or cut in the circuit board. The PCM175x-Q1 family of devices should be oriented with the digital I/O pins facing the ground plane split or cut to allow for short, direct connections to the digital audio interface and control signals originating from the digital section of the board.

11.2 Layout Example

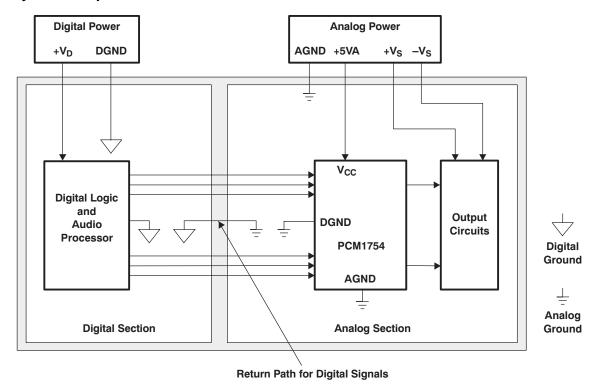


Figure 38. Recommended PCB Layout



Layout Example (continued)

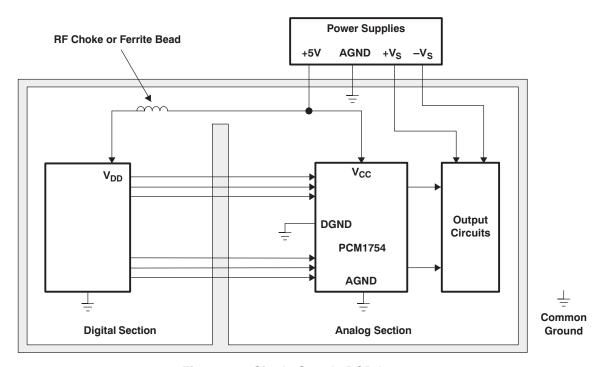


Figure 39. Single-Supply PCB Layout



12 Device and Documentation Support

12.1 Documentation Support

12.1.1 Related Documentation

For related documentation see the following:

- Dynamic Performance Testing of Digital Audio D/A Converters, SBAA055
- OPA2353, High-Speed, Single-Supply, Rail-to-Rail Operational Amplifiers MicroAmplifier™ Series, SBOS103
- OPA2134, SoundPlus[™] High Performance Audio Operational Amplifiers, SBOS058
- PLL1705, PLL1706 3.3-V Dual PLL Multiclock Generator, SLES046

12.2 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 7. Related Links

| PARTS | PRODUCT FOLDER | SAMPLE & BUY | TECHNICAL DOCUMENTS | TOOLS & SOFTWARE | SUPPORT & COMMUNITY | |
|------------|----------------|--------------|---------------------|---------------------|---------------------|--|
| PCM1754-Q1 | Click here | Click here | Click here | Click here | Click here | |
| PCM1753-Q1 | Click here | Click here | Click here | Click here | Click here | |

12.3 Community Resource

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

12.4 Trademarks

E2E is a trademark of Texas Instruments.

System Two, Audio Precision are trademarks of Audio Precision, Inc.

All other trademarks are the property of their respective owners.

12.5 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

12.6 Glossary

SLYZ022 — TI Glossarv.

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGE OPTION ADDENDUM

3-Jun-2014

PACKAGING INFORMATION

| Orderable Device | Status | Package Type | _ | Pins | _ | Eco Plan | Lead/Ball Finish | MSL Peak Temp | Op Temp (°C) | Device Marking | Samples |
|------------------|--------|--------------|---------|------|------|----------------------------|------------------|---------------------|--------------|----------------|---------|
| | (1) | | Drawing | | Qty | (2) | (6) | (3) | | (4/5) | |
| PCM1753TDBQRQ1 | ACTIVE | SSOP | DBQ | 16 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-3-260C-168 HR | -40 to 105 | P1753T | Samples |
| PCM1754TDBQRQ1 | ACTIVE | SSOP | DBQ | 16 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-3-260C-168 HR | -40 to 105 | P1754Q | Samples |

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE OPTION ADDENDUM

3-Jun-2014

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF PCM1753-Q1, PCM1754-Q1:

• Catalog: PCM1753, PCM1754

NOTE: Qualified Version Definitions:

• Catalog - TI's standard catalog product

PACKAGE MATERIALS INFORMATION

www.ti.com 3-Jun-2014

TAPE AND REEL INFORMATION





| Α0 | Dimension designed to accommodate the component width |
|----|---|
| | Dimension designed to accommodate the component length |
| K0 | Dimension designed to accommodate the component thickness |
| W | Overall width of the carrier tape |
| P1 | Pitch between successive cavity centers |

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

| Device | Package Type | Package Drawing | | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|----------------|-----------------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| PCM1753TDBQRQ1 | SSOP | DBQ | 16 | 2000 | 330.0 | 12.4 | 6.4 | 5.2 | 2.1 | 8.0 | 12.0 | Q1 |
| PCM1754TDBQRQ1 | SSOP | DBQ | 16 | 2000 | 330.0 | 12.4 | 6.4 | 5.2 | 2.1 | 8.0 | 12.0 | Q1 |

PACKAGE MATERIALS INFORMATION

www.ti.com 3-Jun-2014



*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|----------------|--------------|-----------------|------|------|-------------|------------|-------------|
| PCM1753TDBQRQ1 | SSOP | DBQ | 16 | 2000 | 367.0 | 367.0 | 35.0 |
| PCM1754TDBQRQ1 | SSOP | DBQ | 16 | 2000 | 367.0 | 367.0 | 35.0 |

DBQ (R-PDSO-G16)

PLASTIC SMALL-OUTLINE PACKAGE



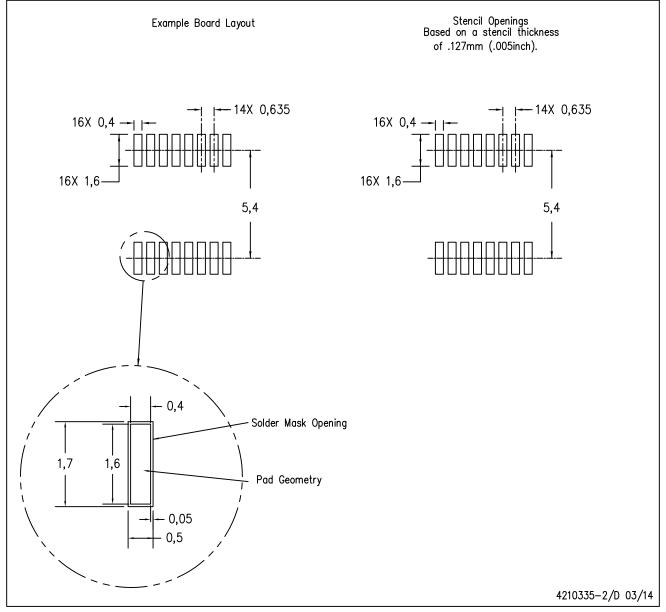
NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15) per side.
- D. Falls within JEDEC MO-137 variation AB.



DBQ (R-PDSO-G16)

PLASTIC SMALL OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.



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